

**Notice of References Cited**

Application/Control No.

09/197,435

Applicant(s)/Patent Under  
Reexamination  
LUPKE ET AL.

Examiner

Stefan Staicovici

Art Unit

1732

Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number	Date	Name	Classification	
		Country Code-Number-Kind Code	MM-YYYY			
	A	US-5704401-A	01-1998	Fukui et al.	138	121
	B	US-4534923-A	08-1985	Lupke	264	156
	C	US-4377545-A	03-1983	Hornbeck	264	167
	D	US-5405569-A	04-1995	Lupke	264	504
	E	US-5335945-A	08-1994	Meyers	285	236
	F	US-4240470-A	12-1980	McPherson et al.	138	109
	G	US-4913473-A	04-1990	Bonnema et al.	285	423
	H	US-4082327-A	04-1978	Sting et al.	285	401
	I	US-5996635-A	12-1999	Hegler	138	109
	J	US-4779651-A	10-1988	Hegler et al.	138	109
	K	US-4865797-A	09-1989	Jarvenkyla	264	508
	L	US- -				
	M	US- -				

**FOREIGN PATENT DOCUMENTS**

*		Document Number	Date	Country	Name	Classification	
		Country Code-Number-Kind Code	MM-YYYY				
	N	- -					
	O	- -					
	P	- -					
	Q	- -					
	R	- -					
	S	- -					
	T	- -					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.